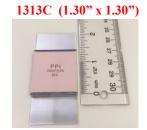


♦ Product Features

High Q, High RF Current/Voltage, High RF Power, Low ESR/ESL, Low Noise, Non-Magnetic Ultra-Stable Performance.



♦ Typical Application Fields

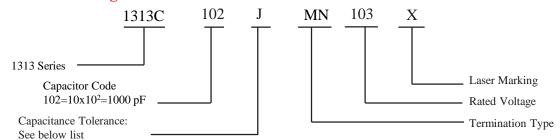
Semiconductor manufacturing, Inductive Heating, Inductively Coupled Plasma systems, Scientific Instruments, Medical, High Energy RF Power Transfer, Matching Circuits.

♦ 1313C Capacitance Table

Cap. pF	Code	Tol.	Rated WVDC	Cap. pF	Code	Tol.	Rated WVDC	Cap. pF	Code	Tol.	Rated WVDC
200	201			1800	182		J,K 10KV Code103	12000	123	J,K J,K	3000V Code302
220	221			2200	222	G,J,K		15000	153		
270	271			2700	272			22000	223		
300	301			3300	332		5000V 68 Code502 82	33000	333		
330	331			4700	472			47000	473		
390	391			5100	512	G,J,K		56000	563		
470	471	G,J,K	10KV Code103	5600	562			68000	683		1000V Code102
560	561			6800	682			82000	823		
680	681			7500	752			100000	104		
820	821			8200	822			120000	124		
1000	102			10000	103						
1200	122										
1500	152										



♦ Part Numbering



Capacitance Tolerance					
Code	G	J	K		
Tolerance	±2%	±5%	±10%		

♦ 1313C Non-Magnetic Lead Type and Dimensions

-	70110	unit: inch (millimeter						eter)		
		Type/ Outlines	Capacitor Dimensions				Lead Dimensions			
Series	Term. Code		Length Lc	Width Wc	Thick -ness Tc	Overlap B	Length LL	Width WL	Thickness TL	Plated Material
1313C	MN	TLTc Microstrip (Non-Mag)			.173 ±.008	-	.787± 0.02 (20.00±	1.299 ± .020 (33.0±	.012 ± .001 (0.30±	Silver- plated Copper
1313C	AN	TL Te LL WL	1.30 +.015	1.20			0.5)	0.5)	0.025)	
		Axial Ribbon (NonMag)	to 010	1.30 ±.010			.669±	0.157	.012	
1313C	FN	TL W	(33.02 +0.38 to -0.25)	(33.02± 0.25)	(4.40 ±0.20)		0.012 (17.00 ± 0.3)	±.008 (4.0± 0.2)	±.001 (0.30± 0.025)	
		Radial Ribbon (Non-Mag)								
1313C	Р	Chip (Non-Mag)				.063 (1.60) max	-	-	-	Non-Mag, Copper Plated 100% Sn

Note: "Non-Mag" means no magnetic materials. All leads are attached with high temperature solder and parts are RoHS Compliant.



♦ Performance

Item	Specifications					
Quality Factor (Q)	Less than 1000pF, Q value more than 2000, Test frequency 1MHz; Greater than 1000pF, Q value more than 2000, Test frequency 1KHz;					
Insulation Resistance (IR)	Test Voltage: 500V 10 ⁵ Megohms min. @ +25°C at rated WVDC. 10 ⁴ Megohms min. @ +125°C at rated WVDC.					
Rated Voltage	See Rated Voltage Table.					
Dielectric Withstanding Voltage (DWV)	150% of Voltage for 5 seconds, 500VDC < Rated Voltage ≦1250VDC 120% of Voltage for 5 seconds, Rated Voltage >1250VDC					
Operating Temperature Range	-55°C to +175°C					
Temperature coefficient (TC)	0±30ppm/°C					
Capacitance Drift	±0.02% or ±0.02pF, whichever is greater.					
Piezoelectric Effects	None					

 $Capacitors \ are \ designed \ and \ manufactured \ to \ meet \ the \ requirements \ of \ MIL-PRF-55681 \ and \ MIL-PRF-123.$

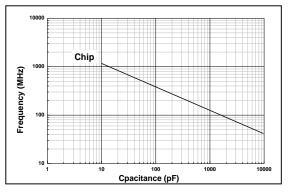
Environmental Tests

Item	Specifications	Method
Thermal shock	DWV: the initial value IR: Shall not be less than 30% of the initial value. Capacitance change: no more than 0.5% or 0.5 pF, whichever is greater.	MIL-STD-202, Method 107, Condition A. At the maximum rated temperature (-55°C and 125°C) stay 30 min, the time of removing shall not be more than 3 minutes. Perform the five cycles.
Moisture resistance		MIL-STD-202, Method 106.
Humidity (steady state)	DWV: the initial value IR: the initial value Capacitance change: no more than 0.3% or 0.3pF, whichever is greater.	MIL-STD-202, Method 103, Condition A, With 1.5 Volts D.C. applied while subjected to an environment of 85°C with 85% relative humidity for 240 hours minimum.
Life	IR: Shall not be less than 30% of the initial value. Capacitance change: no more than 2.0% or 0.5 pF, whichever is greater.	MIL-STD-202, Method 108, for 2000 hours, at 125°C, 120% of Voltage for Capacitors, 500VDC < Rated Voltage ≤ 1250VDC; 100% of Voltage for Capacitors, Rated Voltage >1250VDC.
Terminal strength	Force: 30lbs typical, Duration time: 5 to 10 seconds.	MIL-STD-202, Method 211A, Test condition A. Applied a force and maintained for a period of 5 to 10 seconds. The force shall be in the direction of the axes of the terminations.



♦ 1313C Performance Curves

Self Resonant Frequency vs Capacitance



Test Conditions:

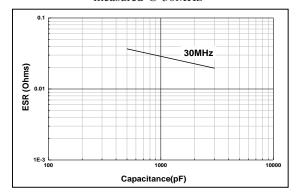
Typical responses for sample placed across a 1.1-inch gap in a 114-milwide Micro-strip on $60\,\mathrm{mil}$ FR4 PCB.

Measurements de-embedded to sample edges using TRL calibration procedures.

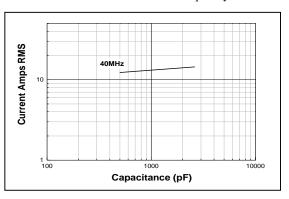




ESR vs Capacitance measured @ 30MHz



1313C Rated Current vs Frequency



Please contact Passive Plus, Inc. to begin discussions for a Custom Assembly.